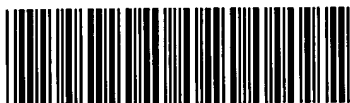


Search Notes

Application/Control No.

10/532,529

Examiner

Karen Cheng

Applicant(s)/Patent under
Reexamination

DUNKEL ET AL.

Art Unit

1626

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 548 | 181 | 12/8/2006 | KC |
| 548 | 200 | 12/8/2006 | KC |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-------------------------------------|-----------|------|
| STN Structure Search (see attached) | 12/7/2006 | KC |
| EAST Search (see attached) | 12/8/2006 | KC |
| Inventor Name Search | 12/6/2006 | KC |
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